

Absolute Maximum Ratings		Values	Units
Symbol	Conditions ¹⁾		
V _{CES}		1200	V
V _{CGR}	R _{GE} = 20 kΩ	1200	V
I _C	T _{case} = 25/85 °C	290 / 200	A
I _{CM}	T _{case} = 25/85 °C; t _p = 1 ms	580 / 400	A
V _{GES}		± 20	V
P _{tot}	per IGBT, T _{case} = 25 °C	1350	W
T _J , (T _{stg})		−40 ... +150 (125)	°C
V _{isol}	AC, 1 min.	2500	V
humidity	DIN 40040	Class F	
climate	DIN IEC 68 T.1	40/125/56	
Inverse Diode			
I _F = −I _C	T _{case} = 25/80 °C	195 / 130	A
I _{FM} = −I _{CM}	T _{case} = 25/80 °C; t _p = 1 ms	580 / 400	A
I _{FSM}	t _p = 10 ms; sin.; T _J = 150 °C	1450	A
I ² t	t _p = 10 ms; T _J = 150 °C	10 500	A ² s

Characteristics					
Symbol	Conditions ¹⁾	min.	typ.	max.	Units
V _{(BR)CES}	V _{GE} = 0, I _C = 4 mA	≥ V _{CES}	–	–	V
V _{GE(th)}	V _{GE} = V _{CE} , I _C = 6 mA	4,5	5,5	6,5	V
I _{CES}	V _{GE} = 0 } T _j = 25 °C	–	0,4	14	mA
	V _{CE} = V _{CES} } T _j = 125 °C	–	12	–	mA
I _{GES}	V _{GE} = 20 V, V _{CE} = 0	–	–	0,32	µA
V _{CESat}	I _C = 150 A { V _{GE} = 15 V;	–	2,1(2,4)	2,45(2,85)	V
V _{CESat}	I _C = 200 A { T _j = 25 (125) °C }	–	2,5(3,0)	–	V
g _{fs}	V _{CE} = 20 V, I _C = 150 A	62	–	–	S
C _{CHC}	per IGBT	–	–	700	pF
C _{ies}	} V _{GE} = 0 V _{CE} = 25 V f = 1 MHz	–	11	15	nF
C _{oes}		–	1,6	2	nF
C _{res}		–	0,8	1	nF
L _{CE}		–	–	20	nH
t _{d(on)}	} V _{CC} = 600 V V _{GE} = –15 V / +15 V ³⁾ I _C = 150 A, ind. load R _{Gon} = R _{Goff} = 7Ω T _j = 125 °C	–	75	–	ns
t _r		–	50	–	ns
t _{d(off)}		–	520	–	ns
t _f		–	50	–	ns
E _{on}		–	21	–	mWs
E _{off}		–	19	–	mWs
Inverse Diode ⁸⁾					
V _F = V _{EC}	I _F = 150 A { V _{GE} = 0 V; T _j = 25 (125) °C }	–	2,0(1,8)	2,5	V
V _F = V _{EC}		–	2,25(2,05)	–	V
V _{TO}	T _j = 125 °C ²⁾	–	1,1	1,2	V
r _t	T _j = 125 °C ²⁾	–	–	7	mΩ
I _{RRM}	I _F = 150 A; T _j = 125 °C ²⁾	–	78	–	A
Q _{rr}	I _F = 150 A; T _j = 125 °C ²⁾	–	19,5	–	µC
Thermal characteristics					
R _{thjc}	per IGBT	–	–	0,09	°C/W
R _{thjc}	per diode	–	–	0,25	°C/W
R _{thch}	per module	–	–	0,038	°C/W

SEM

ITRANS® M

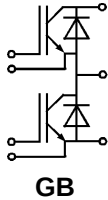
Low Loss IGBT Modules

SKM 200 GB 124 D



SEM

ITRANS 3



- Features
- MOS input (voltage controlled)
 - N channel, homogeneous Silicon structure NPT-IGBT (Non punch through)
 - Low saturation voltage
 - Low inductance case
 - Low tail current with low temperature dependence
 - High short circuit capability, self limiting to 6 * I_{Cnom}
 - Latch-up free
 - Fast & soft inverse CAL diodes ⁸⁾
 - Isolated copper baseplate using DCB Direct Copper Bonding Technology without hard mould
 - Large clearance (12 mm) and creepage distances (20 mm)

- Typical Applications → B 6 – 161
- Switching (not for linear use)
 - Inverter drives
 - UPS

¹⁾ T_{case} = 25 °C, unless otherwise specified

²⁾ I_F = − I_C, V_R = 600 V, −di_F/dt = 1500 A/µs, V_{GE} = 0 V

³⁾ Use V_{GEoff} = −5... −15 V

⁸⁾ CAL = Controlled Axial Lifetime Technology

Cases and mech. data

→ B 6 – 162

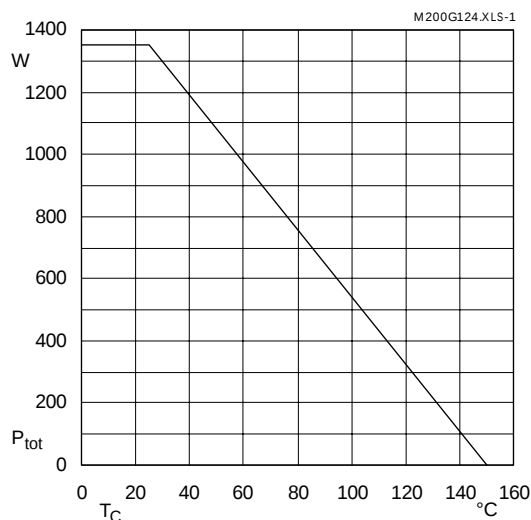


Fig. 1 Rated power dissipation $P_{tot} = f(T_C)$

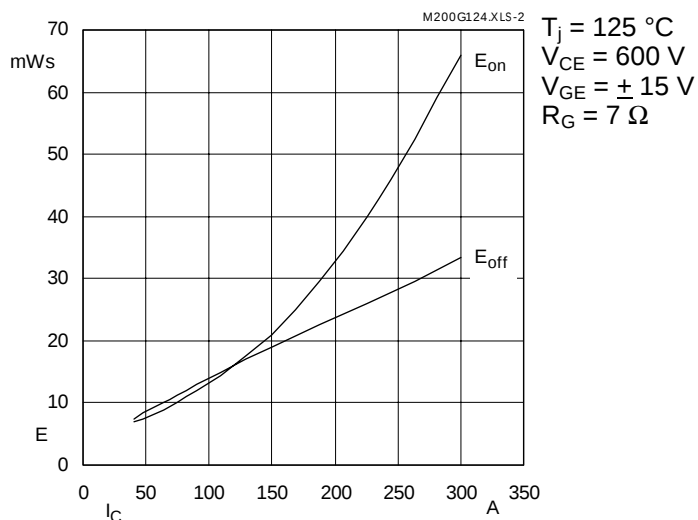


Fig. 2 Turn-on /off energy $= f(I_C)$

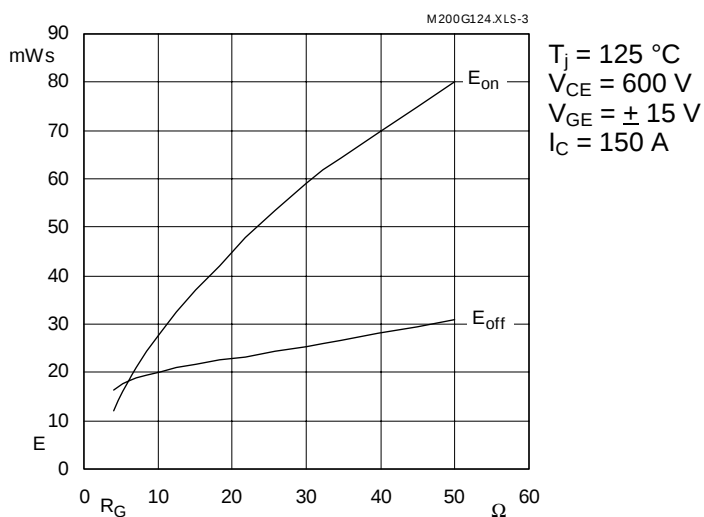


Fig. 3 Turn-on /off energy $= f(R_G)$

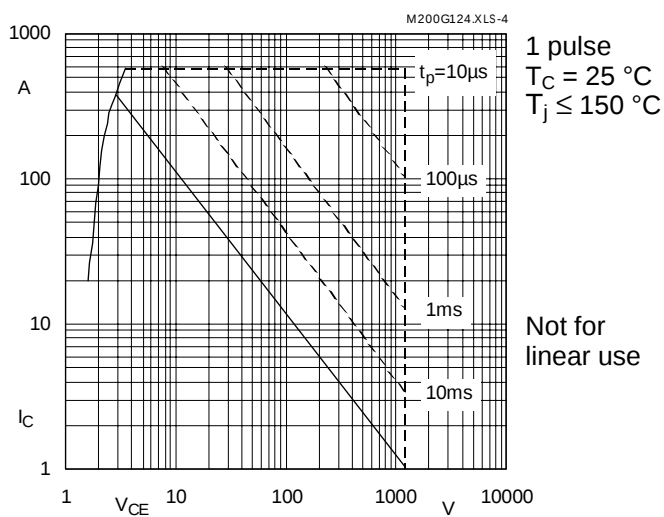


Fig. 4 Maximum safe operating area (SOA) $I_C = f(V_{CE})$

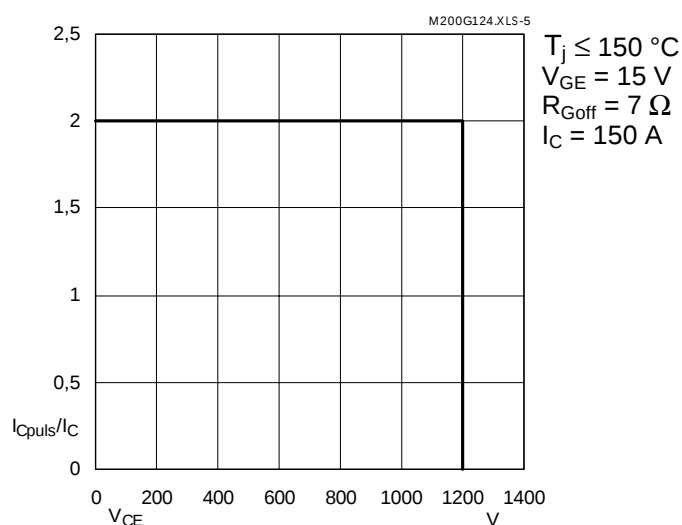


Fig. 5 Turn-off safe operating area (RBSOA)

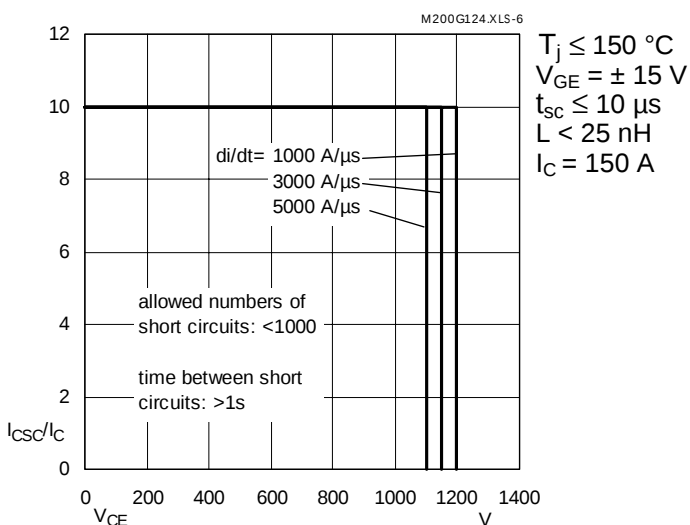


Fig. 6 Safe operating area at short circuit $I_C = f(V_{CE})$

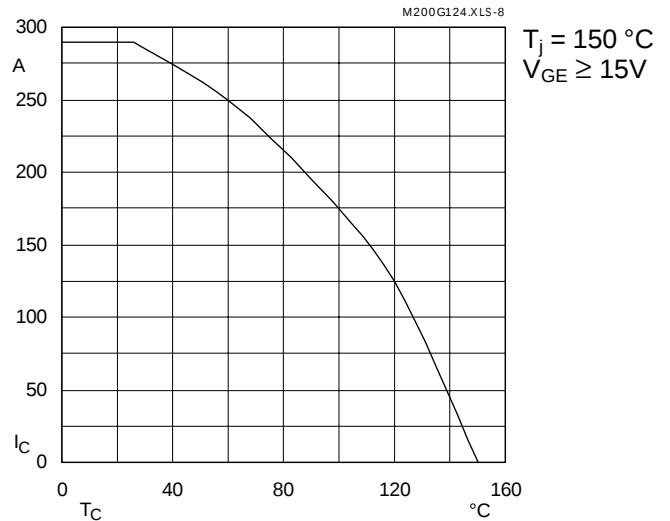


Fig. 8 Rated current vs. temperature $I_C = f(T_C)$

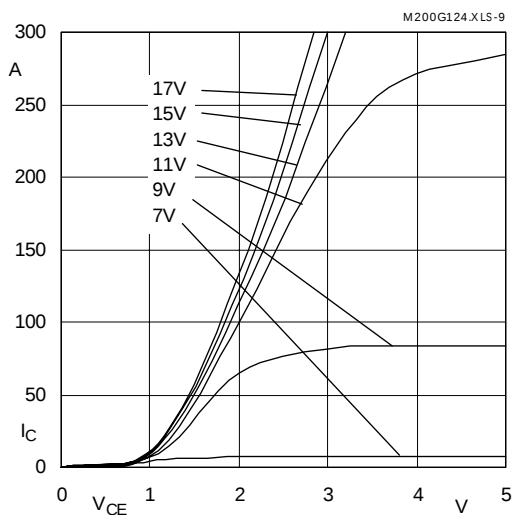


Fig. 9 Typ. output characteristic, $t_p = 80\text{ μs}$; 25 °C

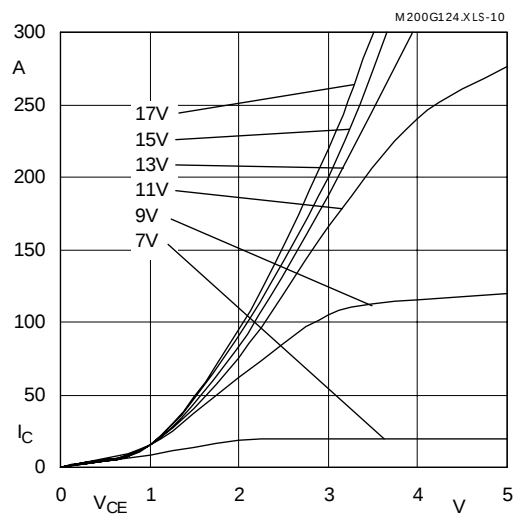


Fig. 10 Typ. output characteristic, $t_p = 80\text{ μs}$; 125 °C

$$P_{\text{cond}(t)} = V_{\text{CEsat}(t)} \cdot I_{\text{C}(t)}$$

$$V_{\text{CEsat}(t)} = V_{\text{CE(To)(Tj)}} + r_{\text{CE(Tj)}} \cdot I_{\text{C}(t)}$$

$$V_{\text{CE(To)(Tj)}} \leq 1,3 + 0,0005 (T_j - 25) [\text{V}]$$

$$\text{typ.: } r_{\text{CE(Tj)}} = 0,0053 + 0,000017 (T_j - 25) [\Omega]$$

$$\text{max.: } r_{\text{CE(Tj)}} = 0,0077 + 0,000023 (T_j - 25) [\Omega]$$

$$\text{valid for } V_{\text{GE}} = +15 \pm 2 \text{ [V]; } I_C > 0,3 I_{\text{Cnom}}$$

Fig. 11 Saturation characteristic (IGBT)
Calculation elements and equations

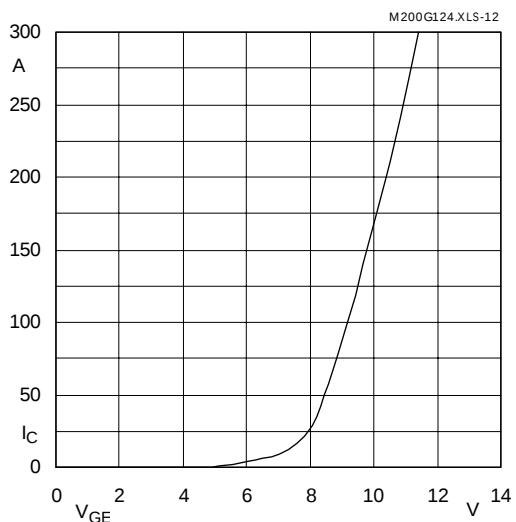
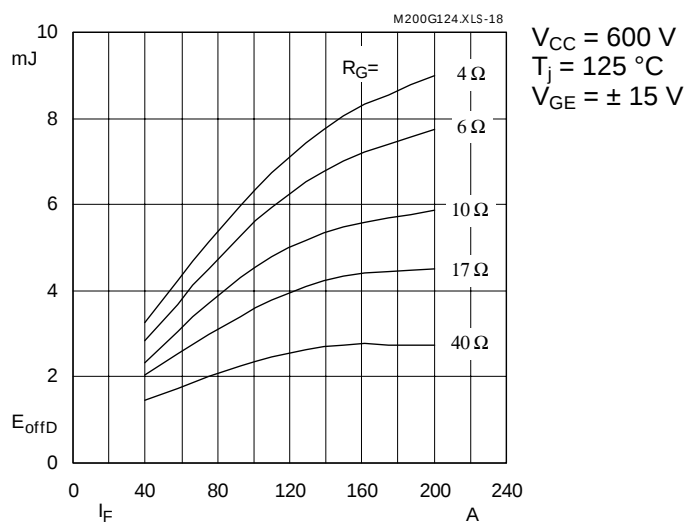
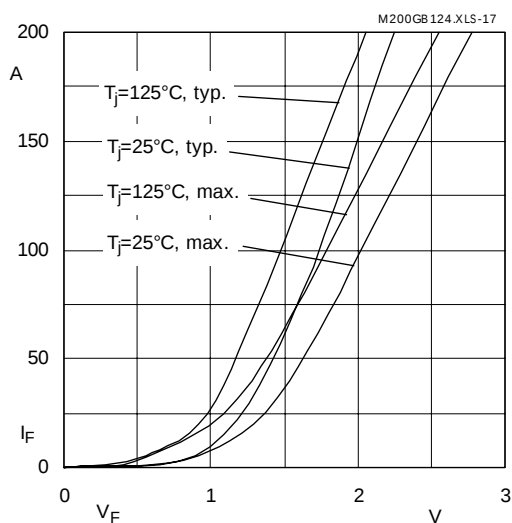
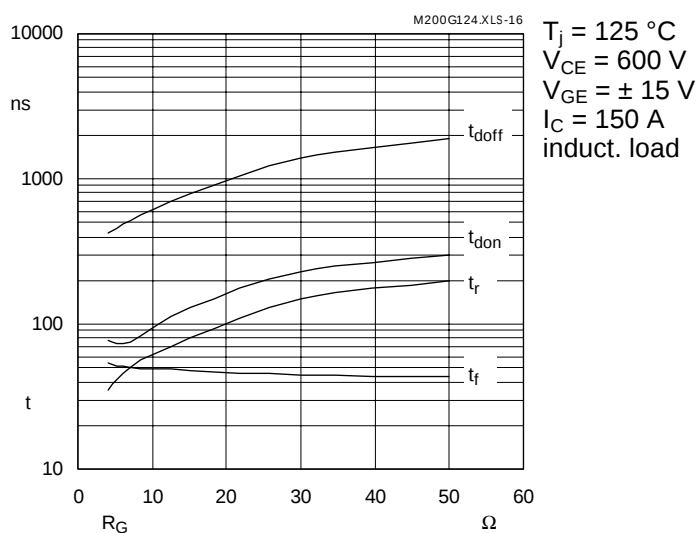
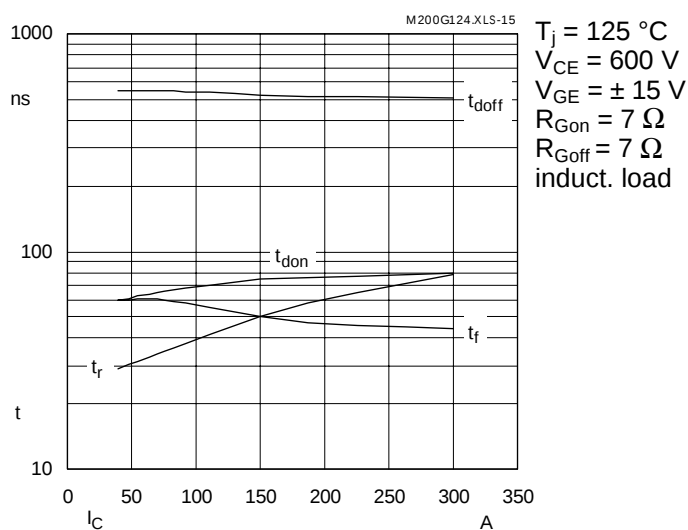
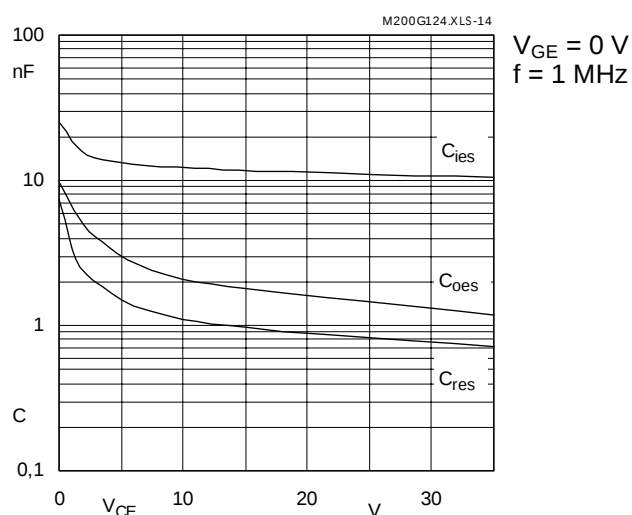
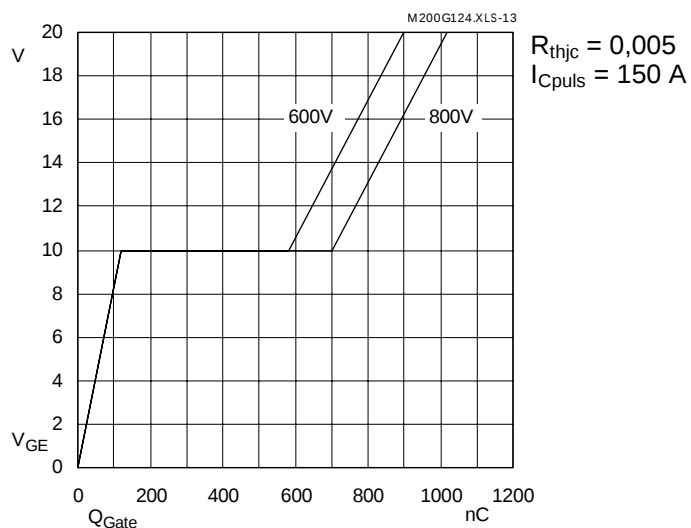


Fig. 12 Typ. transfer characteristic, $t_p = 80\text{ μs}$; $V_{CE} = 20\text{ V}$



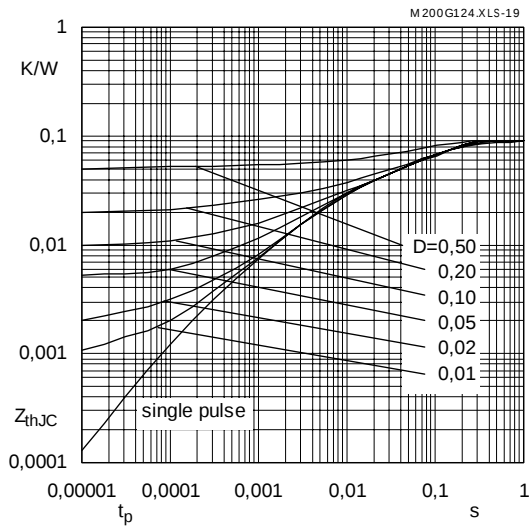


Fig. 19 Transient thermal impedance of IGBT
 $Z_{thJC} = f(t_p)$; $D = t_p / t_c = t_p \cdot f$

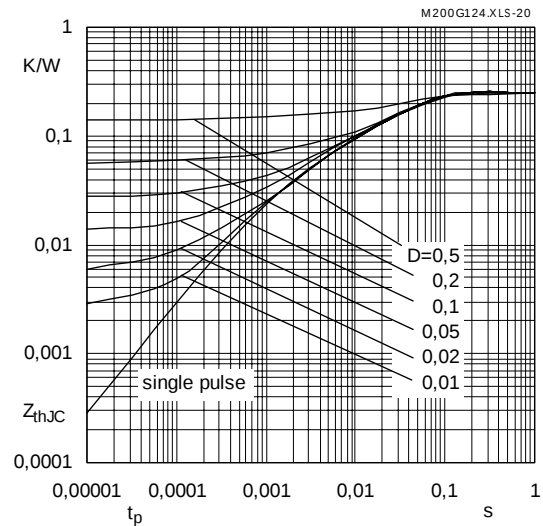


Fig. 20 Transient thermal impedance of inverse CAL diodes $Z_{thJC} = f(t_p)$; $D = t_p / t_c = t_p \cdot f$

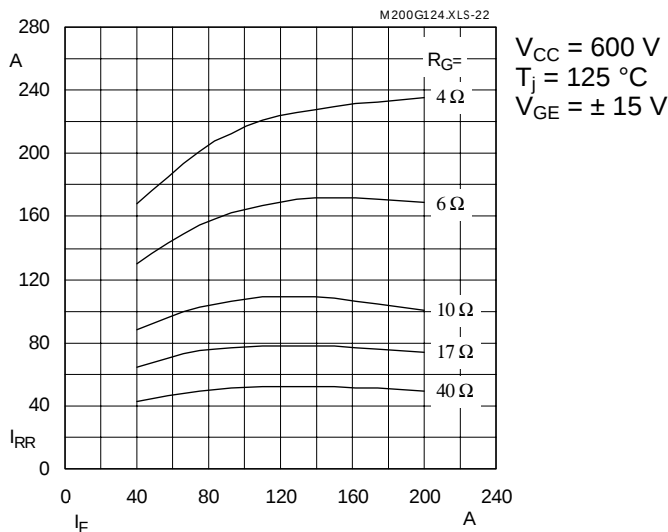


Fig. 22 Typ. CAL diode peak reverse recovery current $I_{RR} = f(I_F; R_G)$

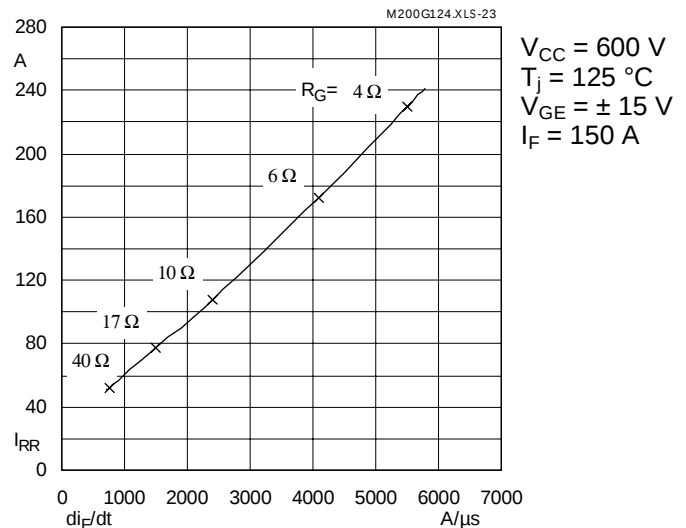


Fig. 23 Typ. CAL diode peak reverse recovery current $I_{RR} = f(di/dt)$

Typical Applications

include

- Switched mode power supplies
- DC servo and robot drives
- Inverters
- DC choppers
- AC motor speed control
- UPS Uninterruptable power supplies
- General power switching applications
- Electronic (also portable) welders

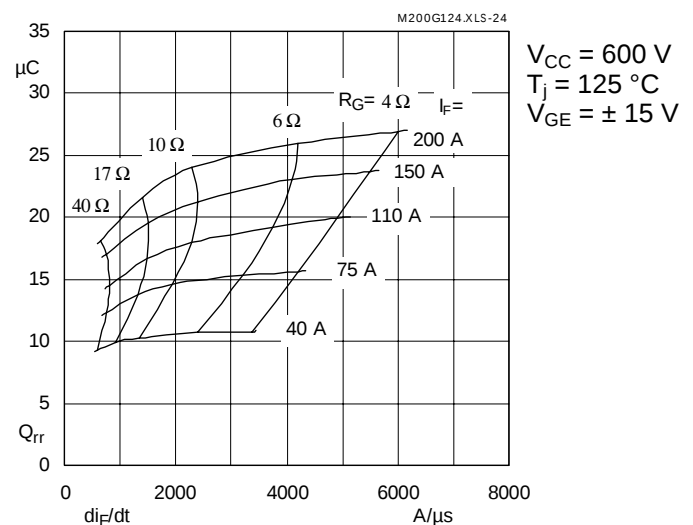
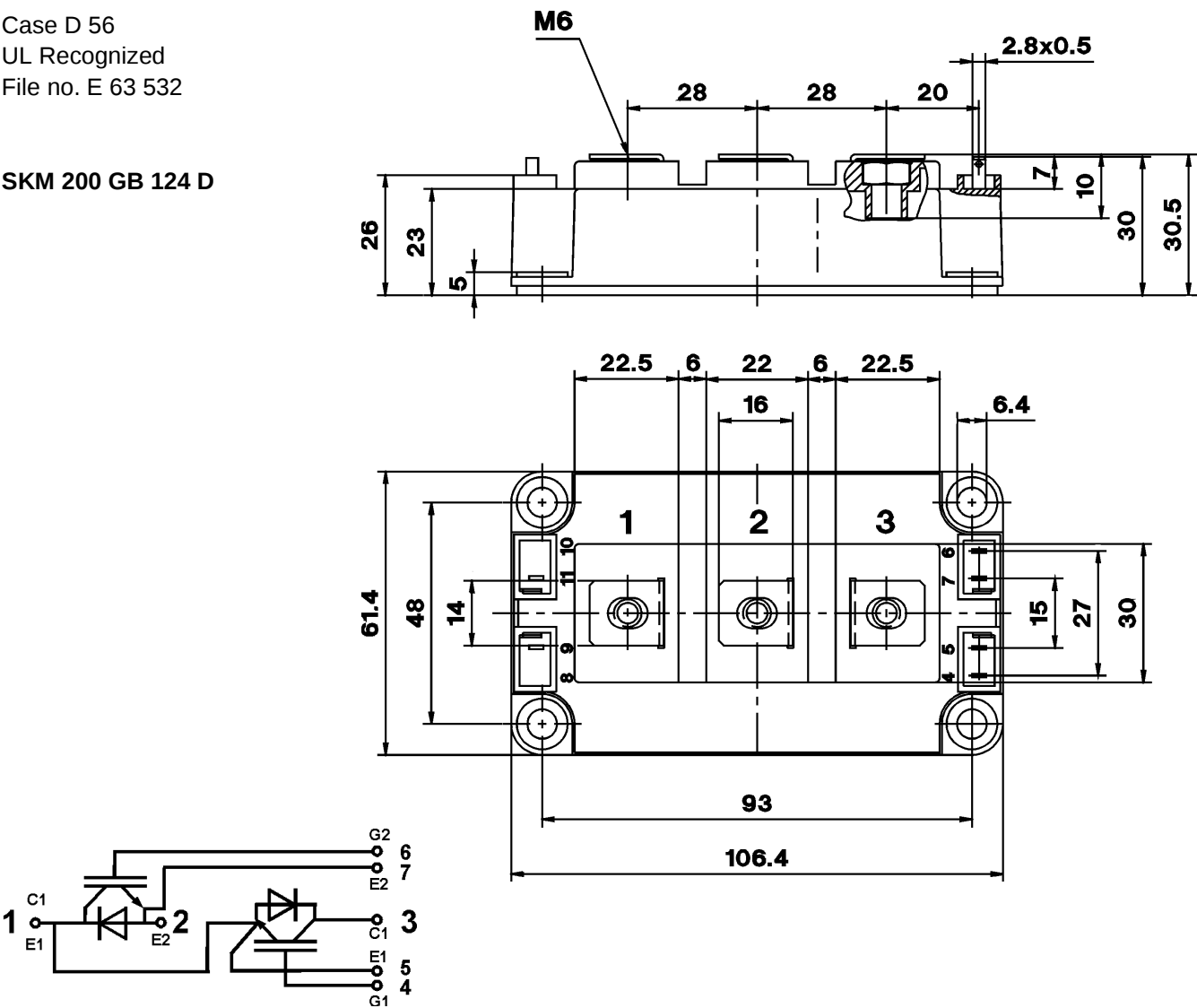


Fig. 24 Typ. CAL diode recovered charge

SEMITRANS 3

Case D 56
UL Recognized
File no. E 63 532

SKM 200 GB 124 D



Dimensions in mm

Case outline and circuit diagram

Mechanical Data			Values			Units
Symbol	Conditions		min.	typ.	max.	
M ₁	to heatsink, SI Units	(M6)	3	—	5	Nm
	to heatsink, US Units		27	—	44	lb.in.
M ₂	for terminals, SI Units	(M6)	2,5	—	5	Nm
	for terminals, US Units		22	—	44	lb.in.
a			—	—	5x9,81	m/s ²
w			—	—	325	g

This is an electrostatic discharge sensitive device (ESDS). Please observe the international standard IEC 747-1, Chapter IX.

Three devices are supplied in one SEMIBOX A without mounting hardware, which can be ordered separately under Ident No. 33321100 (for 10 SEMITRANS 3). Larger packing units of 12 and 20 pieces are used if suitable
Accessories → B 6 – 4.
SEMIBOX → C – 1.